

Notice of References Cited		Application/Control No. 09/922,411	Applicant(s)/Patent Under Reexamination KHAZEI, MEHYAR	
		Examiner Stacy A Whitmore	Art Unit 2812	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	Marano, "Field tests on telecommunication systems: an evaluation of the radiated emissions by near field probe". IEEE, 1998, pgs. 918-923.
	W	Childs, "Fast interactive EMC analysis for design engineers". IEEE, 1995, pgs. 1-7
	X	Natesan, "Performance driven placement for cell-based design". IEEE, 1995, pgs. 237-240.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.